

# Notice of References Cited

Application Control No  
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Applicant(s) Patent Under Reexam  
Terada et al.

Examiner  
Shin-Lin Chen

Art Unit  
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Page 1 of 1

## U.S. PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,236,704	8/1993	Fujioka et al.	424	85.1
B					
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D					
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M					

## FOREIGN PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
N	WO 96/40265	12/1996	WIPO	Szoka et al.	----	----
O	WO 96/29096	3/1996	JPN	Kuma et al.	----	----
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## NON-PATENT DOCUMENTS

Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages					
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<sup>1</sup> Dates in MM-YYYY format are publication dates.

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